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Team Nexperia



40 V, 1 A PNP low V_{CEsat} BISS transistor Rev. 04 — 29 July 2008

Product data sheet

1. **Product profile**

1.1 General description

PNP low V_{CEsat} Breakthrough In Small Signal (BISS) transistor in a SOT23 (TO-236AB) small Surface-Mounted Device (SMD) plastic package.

NPN complement: PBSS4140T.

1.2 Features

- Low collector-emitter saturation voltage V_{CEsat}
- High collector current capability I_C and I_{CM}
- High collector current gain (h_{FE}) at high I_C
- High efficiency due to less heat generation

1.3 Applications

- General-purpose switching and muting
- LCD backlighting
- Supply line switching circuits
- Battery-driven equipment (mobile phones, video cameras and handheld devices)

1.4 Quick reference data

Table 1. Quick reference data

Parameter	Conditions	Min	Тур	Max	Unit
collector-emitter voltage	open base	-	-	-40	V
collector current		-	-	–1	Α
peak collector current	single pulse; $t_p \le 1 \text{ ms}$	-	-	-2	Α
collector-emitter saturation resistance	$I_C = -500 \text{ mA};$ $I_B = -50 \text{ mA}$	<u>[1]</u> -	300	< 500	mΩ
	collector-emitter voltage collector current peak collector current collector-emitter	$ \begin{array}{ll} \text{collector-emitter voltage} & \text{open base} \\ \\ \text{collector current} & \text{single pulse;} \\ \\ \text{t}_p \leq 1 \text{ ms} \\ \\ \text{collector-emitter} & \text{I}_C = -500 \text{ mA;} \\ \end{array} $	$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	$ \begin{array}{cccccccccccccccccccccccccccccccccccc$

[1] Pulse test: $t_p \le 300 \ \mu s$; $\delta \le 0.02$.



40 V, 1 A PNP low V_{CEsat} BISS transistor

2. Pinning information

Table 2. Pinning

Iddic 2.	i iiiiiiig		
Pin	Description	Simplified outline	Graphic symbol
1	base		_
2	emitter	<u> 3</u>	3
3	collector	1 2	1—
			006aab259

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PBSS5140T	-	plastic surface-mounted package; 3 leads	SOT23

4. Marking

Table 4. Marking codes

Type number	Marking code ^[1]
PBSS5140T	*2H

[1] * = -: made in Hong Kong

* = p: made in Hong Kong

* = t: made in Malaysia

* = W: made in China

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{CBO}	collector-base voltage	open emitter	-	-40	V
V_{CEO}	collector-emitter voltage	open base	-	-40	V
V_{EBO}	emitter-base voltage	open collector	-	- 5	V
I _C	collector current		-	-1	Α
I _{CM}	peak collector current	single pulse; $t_p \le 1 \text{ ms}$	-	-2	Α
I _{BM}	peak base current	single pulse; t _p ≤ 1 ms	-	–1	Α

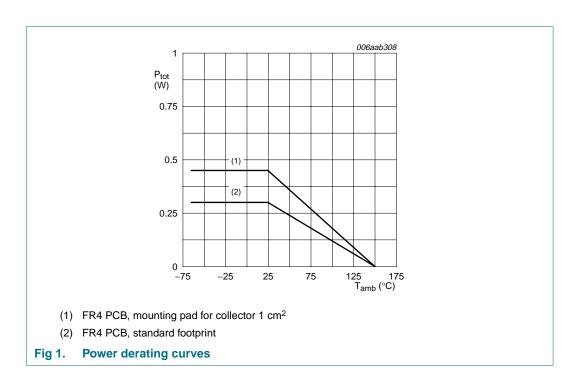
40 V, 1 A PNP low V_{CEsat} BISS transistor

Table 5. Limiting values ...continued
In accordance with the Absolute Maximum Rating System (IEC 60134).

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Symbol	Parameter	Conditions	Min	Max	Unit
P _{tot}	total power dissipation	$T_{amb} \le 25 ^{\circ}C$			
			[1] -	300	mW
			[2] -	450	mW
Tj	junction temperature		-	150	°C
T _{amb}	ambient temperature		–65	+150	°C
T _{stg}	storage temperature		– 65	+150	°C

^[1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.

^[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm².



6. Thermal characteristics

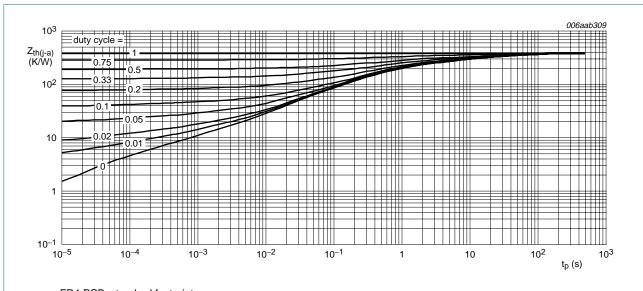
Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-a)}		in free air				
junction to ambient		<u>[1]</u> _	-	417	K/W	
			[2] _	-	278	K/W

^[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

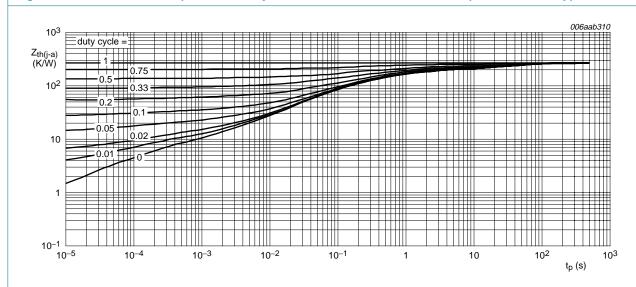
^[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm².

40 V, 1 A PNP low V_{CEsat} BISS transistor



FR4 PCB, standard footprint

Fig 2. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values



FR4 PCB, mounting pad for collector 1 cm²

Fig 3. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

40 V, 1 A PNP low V_{CEsat} BISS transistor

7. Characteristics

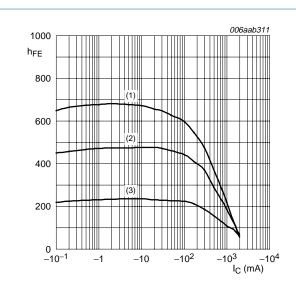
Table 7. Characteristics

 $T_{amb} = 25 \,^{\circ}C$ unless otherwise specified.

uiiib -							
Symbol	Parameter	Conditions	М	in	Тур	Max	Unit
I _{CBO}	collector-base cut-off	$V_{CB} = -40 \text{ V}; I_E = 0 \text{ A}$	-		-	-100	nA
	current	$V_{CB} = -40 \text{ V}; I_E = 0 \text{ A};$ $T_j = 150 ^{\circ}\text{C}$	-		-	-50	μΑ
I _{CEO}	collector-emitter cut-off current	$V_{CE} = -30 \text{ V}; I_B = 0 \text{ A}$	-		-	-100	nA
I _{EBO}	emitter-base cut-off current	$V_{EB} = -5 \text{ V}; I_C = 0 \text{ A}$	-		-	-100	nA
h _{FE}	DC current gain	$V_{CE} = -5 \text{ V}; I_{C} = -1 \text{ mA}$	30	00	-	-	
		$V_{CE} = -5 \text{ V}; I_{C} = -100 \text{ mA}$	30	00	-	800	
		$V_{CE} = -5 \text{ V}; I_{C} = -500 \text{ mA}$	[1] 25	50	-	-	
		$V_{CE} = -5 \text{ V}; I_{C} = -1 \text{ A}$	<u>[1]</u> 16	60	-	-	
V _{CEsat}	collector-emitter	$I_C = -100 \text{ mA}; I_B = -1 \text{ mA}$	-		-	-200	mV
	saturation voltage	$I_C = -500 \text{ mA}; I_B = -50 \text{ mA}$	<u>[1]</u> -		-	-250	mV
		$I_C = -1 A$; $I_B = -100 \text{ mA}$	<u>[1]</u> -		-	-500	mV
R _{CEsat}	collector-emitter saturation resistance	$I_C = -500 \text{ mA}; I_B = -50 \text{ mA}$	[1] -		300	< 500	mΩ
V_{BEsat}	base-emitter saturation voltage	$I_C = -1 \text{ A}; I_B = -50 \text{ mA}$	[1] -		-	-1.1	V
V_{BEon}	base-emitter turn-on voltage	$V_{CE} = -5 \text{ V}; I_C = -1 \text{ A}$	-		-	-1	V
t _d	delay time	$V_{CC} = -10 \text{ V}; I_C = -0.5 \text{ A};$	-		10	-	ns
t _r	rise time	¯ I _{Bon} = −25 mA; − I _{Boff} = 25 mA			31	-	ns
t _{on}	turn-on time	180II — 20 IIIA			41	-	ns
ts	storage time				195	-	ns
t _f	fall time		_		65	-	ns
t _{off}	turn-off time		-		260	-	ns
f⊤	transition frequency	$V_{CE} = -10 \text{ V}; I_{C} = -50 \text{ mA};$ f = 100 MHz	15	50	-	-	MHz
C _c	collector capacitance	$V_{CB} = -10 \text{ V}; I_E = i_e = 0 \text{ A};$ f = 1 MHz	-		-	12	pF

^[1] Pulse test: $t_p \leq 300~\mu s;~\delta \leq 0.02.$

40 V, 1 A PNP low V_{CEsat} BISS transistor



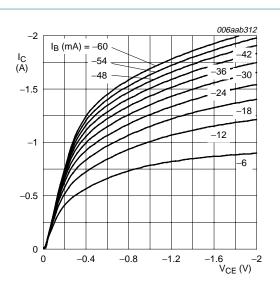
$$V_{CE} = -5 \text{ V}$$

(1)
$$T_{amb} = 100 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

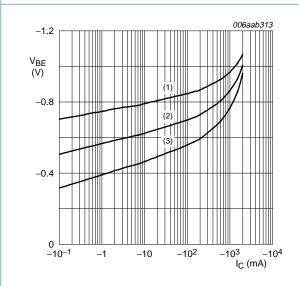
(3) $T_{amb} = -55 \,^{\circ}C$

Fig 4. DC current gain as a function of collector current; typical values



 $T_{amb} = 25 \, ^{\circ}C$

Fig 5. Collector current as a function of collector-emitter voltage; typical values



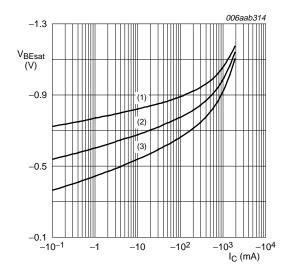


(1) $T_{amb} = -55 \, ^{\circ}C$

(2) $T_{amb} = 25 \, ^{\circ}C$

(3) $T_{amb} = 100 \, ^{\circ}C$

Fig 6. Base-emitter voltage as a function of collector current; typical values



 $I_{\rm C}/I_{\rm B} = 20$

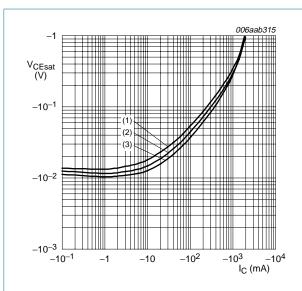
(1) $T_{amb} = -55 \, ^{\circ}C$

(2) $T_{amb} = 25 \, ^{\circ}C$

(3) $T_{amb} = 100 \, ^{\circ}C$

Fig 7. Base-emitter saturation voltage as a function of collector current; typical values

40 V, 1 A PNP low V_{CEsat} BISS transistor



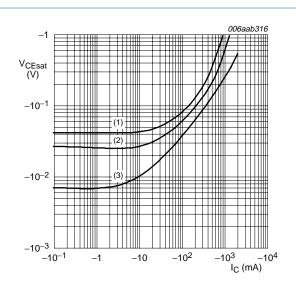
$$I_{\rm C}/I_{\rm B} = 20$$

(1)
$$T_{amb} = 100 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3)
$$T_{amb} = -55 \,^{\circ}C$$

Fig 8. Collector-emitter saturation voltage as a function of collector current; typical values



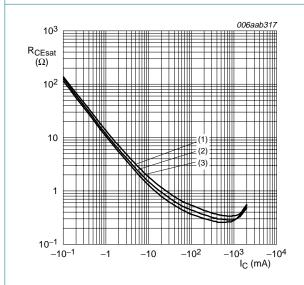
$$T_{amb} = 25 \, ^{\circ}C$$

(1)
$$I_C/I_B = 100$$

(2)
$$I_C/I_B = 50$$

(3)
$$I_C/I_B = 10$$

Fig 9. Collector-emitter saturation voltage as a function of collector current; typical values



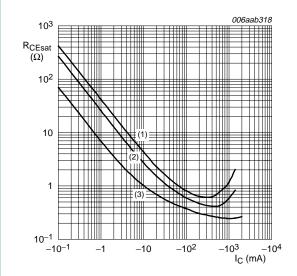
$$I_{\rm C}/I_{\rm B} = 20$$

(1)
$$T_{amb} = 100 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3)
$$T_{amb} = -55 \, ^{\circ}C$$

Fig 10. Collector-emitter saturation resistance as a function of collector current; typical values



$$T_{amb} = 25 \, ^{\circ}C$$

(1)
$$I_C/I_B = 100$$

(2)
$$I_C/I_B = 50$$

(3)
$$I_C/I_B = 10$$

Fig 11. Collector-emitter saturation resistance as a function of collector current; typical values

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40 V, 1 A PNP low V_{CEsat} BISS transistor

8. Test information

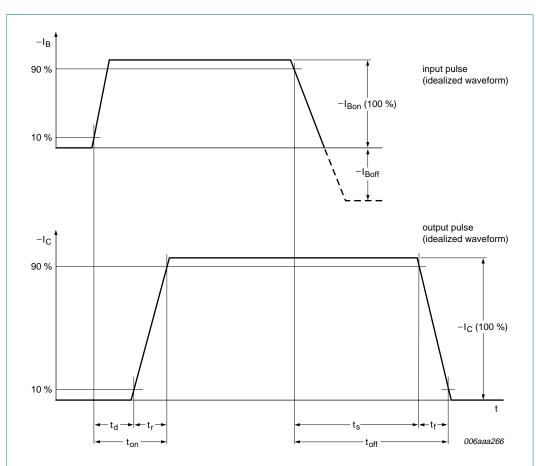
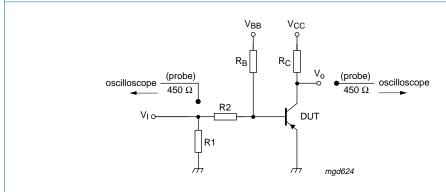


Fig 12. BISS transistor switching time definition

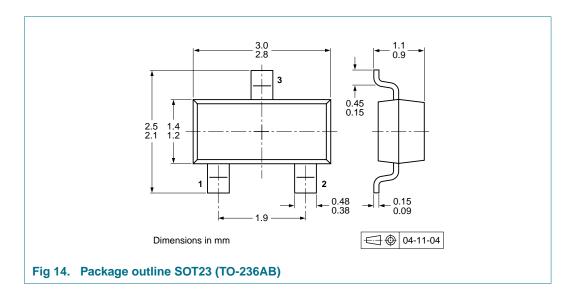


 $V_{CC} = -10 \text{ V}; I_C = -0.5 \text{ A}; I_{Bon} = -25 \text{ mA}; I_{Boff} = 25 \text{ mA}$

Fig 13. Test circuit for switching times

40 V, 1 A PNP low V_{CEsat} BISS transistor

9. Package outline



10. Packing information

Table 8. Packing methods

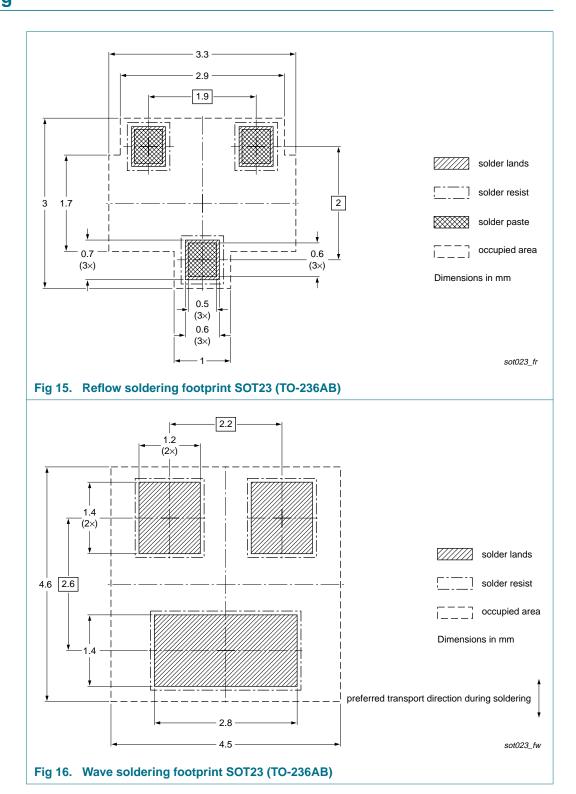
The indicated -xxx are the last three digits of the 12NC ordering code.[1]

Type number	Package	Description	Packing q	uantity
			3000	10000
PBSS5140T	SOT23	4 mm pitch, 8 mm tape and reel	-215	-235

[1] For further information and the availability of packing methods, see Section 14.

40 V, 1 A PNP low V_{CEsat} BISS transistor

11. Soldering



40 V, 1 A PNP low V_{CEsat} BISS transistor

12. Revision history

Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PBSS5140T_4	20080729	Product data sheet	-	PBSS5140T_3
Modifications:		f this data sheet has been NXP Semiconductors.	redesigned to comply v	vith the new identity
	 Legal texts h 	ave been adapted to the n	ew company name whe	re appropriate.
	 Table 4 "Mar 	king codes": marking code	corrected	
	 Table 5 "Limi 	ting values": conditions ad	ded for I_{CM} and I_{BM}	
	 Figure 1, 2 a 	nd <u>3</u> : added		
	 <u>Table 7</u>: R_{CEsat} redefined to collector-emitter saturation resistance 			
	• Figure 4, 6, 8	and 10: updated		
	• <u>Figure 5, 7, 9</u>	and <u>11</u> : added		
	 Section 8 "Te 	est information": added		
	• <u>Figure 14</u> : su	perseded by minimized pa	ackage outline drawing	
	 Section 11 "S 	Soldering": added		
	 Section 13 "L 	<u>egal information": updated</u>	t	
PBSS5140T_3	20040107	Product specification	-	PBSS5140T_2
PBSS5140T_2	20010720	Product specification	-	PBSS5140T_1
PBSS5140T_1	20001116	Product specification	-	-

40 V, 1 A PNP low V_{CEsat} BISS transistor

13. Legal information

13.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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NTE15 NTE16001